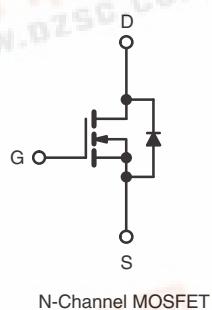


## Power MOSFET

PRODUCT SUMMARY		
V <sub>DS</sub> (V)	60	
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 5 V	0.20
Q <sub>g</sub> (Max.) (nC)		8.4
Q <sub>gs</sub> (nC)		3.5
Q <sub>gd</sub> (nC)		6.0
Configuration		Single

I<sup>2</sup>PAK (TO-262)

D<sup>2</sup>PAK (TO-263)


### FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Advanced Process Technology
- Surface Mount (IRLZ14S, SiHLZ14S)
- Low-Profile Through-Hole (IRLZ14L, SiHLZ14L)
- 175 °C Operating Temperature
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC



### DESCRIPTION

Third generation Power MOSFETs from Vishay utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that Power MOSFETs are well known for, provides the designer with an extremely efficient reliable device for use in a wide variety of applications.

The D<sup>2</sup>PAK is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and lowest possible on-resistance in any existing surface mount package. The D<sup>2</sup>PAK is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

The through-hole version (IRLZ14L, SiHLZ14L) is available for low-profile applications.

### ORDERING INFORMATION

Package	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-262)	I <sup>2</sup> PAK (TO-262)
Lead (Pb)-free and Halogen-free	SiHLZ14S-GE3	SiHLZ14STR-GE3 <sup>a</sup>	SiHLZ14STRR-GE3 <sup>a</sup>	-
Lead (Pb)-free	IRLZ14SPbF	-	IRLZ14STRRPbF <sup>a</sup>	-
	SiHLZ14S-E3	-	SiHLZ14STR-E3	-
SnPb	IRLZ14S	-	IRLZ14TRR <sup>a</sup>	IRLZ14L
	SiHLZ14S	-	SiHLZ14STR <sup>a</sup>	SiHLZ14L

#### Note

a. See device orientation.

### ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25 °C, unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage <sup>e</sup>	V <sub>DS</sub>	60	V
Gate-Source Voltage	V <sub>GS</sub>	± 10	
Continuous Drain Current	V <sub>GS</sub> at 5 V	T <sub>C</sub> = 25 °C	I <sub>D</sub>
		T <sub>C</sub> = 100 °C	
Pulsed Drain Current <sup>a, e</sup>	I <sub>DM</sub>	40	A
Linear Derating Factor		0.29	W/°C
Single Pulse Avalanche Energy <sup>b, e</sup>	E <sub>AS</sub>	68	mJ
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	43	W
		3.7	
Peak Diode Recovery dV/dt <sup>c, e</sup>	dV/dt	4.5	V/ns
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	
Soldering Recommendations (Peak Temperature)	for 10 s	300 <sup>d</sup>	°C

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. V<sub>DD</sub> = 25 V, starting T<sub>J</sub> = 25 °C, L = 790 μH, R<sub>g</sub> = 25 Ω, I<sub>AS</sub> = 10 A (see fig. 12).

c. I<sub>SD</sub> ≤ 10 A, dI/dt ≤ 90 A/μs, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 175 °C.

d. 1.6 mm from case.

e. Uses IRLZ14, SiHLZ14 data and test conditions.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

**THERMAL RESISTANCE RATINGS**

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.5	

**Note**

a. When mounted on 1" square PCB (FR-4 or G-10 material).

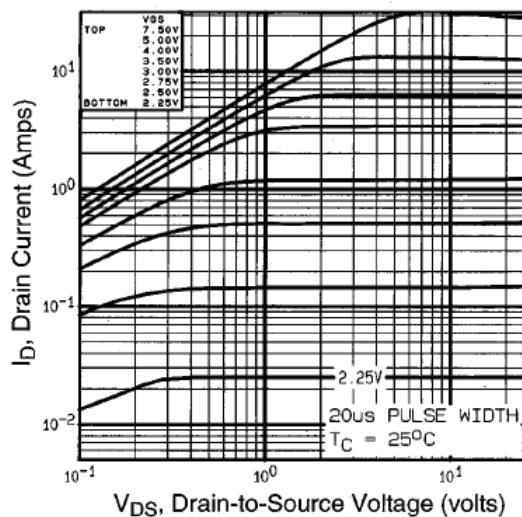
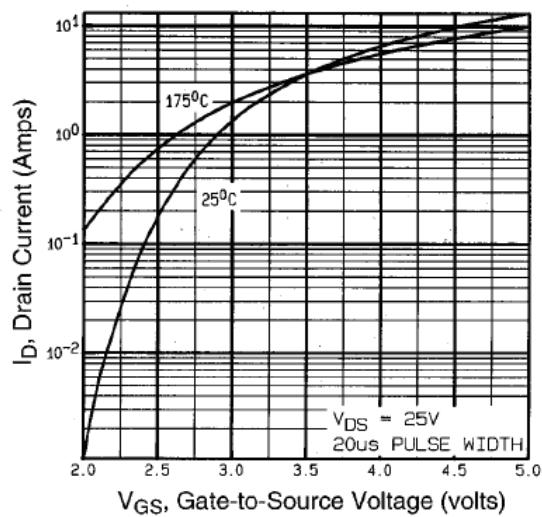
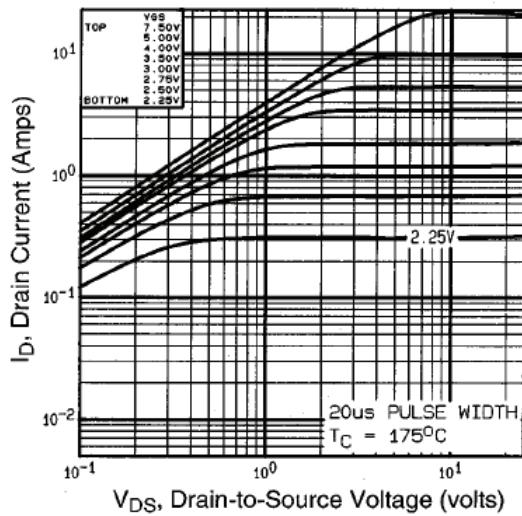
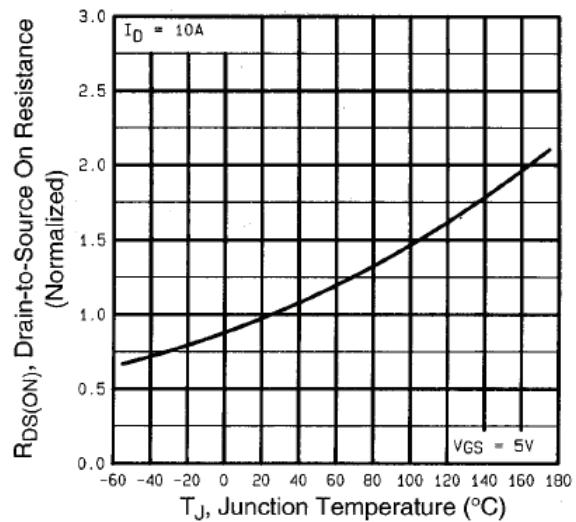
**SPECIFICATIONS** ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
<b>Static</b>								
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		60	-	-	V	
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.07	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		1.0	-	2.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 10 V		-	-	± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V		-	-	25	μA	
		V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C		-	-	250		
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 5 V	I <sub>D</sub> = 6.0 A <sup>b</sup>	-	-	0.2	Ω	
		V <sub>GS</sub> = 4 V	I <sub>D</sub> = 5.0 A <sup>b</sup>	-	-	0.28		
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 25 V, I <sub>D</sub> = 6.0 A		3.5	-	-	S	
<b>Dynamic</b>								
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5		-	400	-	pF	
Output Capacitance	C <sub>oss</sub>			-	170	-		
Reverse Transfer Capacitance	C <sub>rss</sub>			-	42	-		
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> = 5 V	I <sub>D</sub> = 10 A, V <sub>DS</sub> = 48 V, see fig. 6 and 13 <sup>b</sup>	-	-	8.4	nC	
Gate-Source Charge	Q <sub>gs</sub>			-	-	3.5		
Gate-Drain Charge	Q <sub>gd</sub>			-	-	6.0		
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 30 V, I <sub>D</sub> = 10 A, R <sub>g</sub> = 12 Ω, R <sub>D</sub> = 2.8 Ω, see fig. 10 <sup>b</sup>		-	9.3	-	ns	
Rise Time	t <sub>r</sub>			-	110	-		
Turn-Off Delay Time	t <sub>d(off)</sub>			-	17	-		
Fall Time	t <sub>f</sub>			-	26	-		
Internal Source Inductance	L <sub>S</sub>	Between lead, and center of die contact		-	7.5	-	nH	
<b>Drain-Source Body Diode Characteristics</b>								
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	A	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	40		
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 10 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.6	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 10 A, dI/dt = 100 A/μs <sup>b</sup>		-	93	130	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	340	650	nC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )						

**Notes**

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

**Fig. 1 - Typical Output Characteristics**

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 2 - Typical Output Characteristics**

**Fig. 4 - Normalized On-Resistance vs. Temperature**

# IRLZ14S, IRLZ14L, SiHLZ14S, SiHLZ14L

Vishay Silicon IRLZ14L, SiHLZ14S, SiHLZ14L"供应商

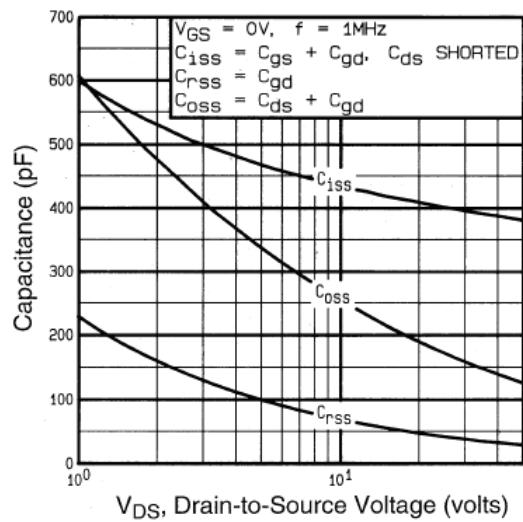


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

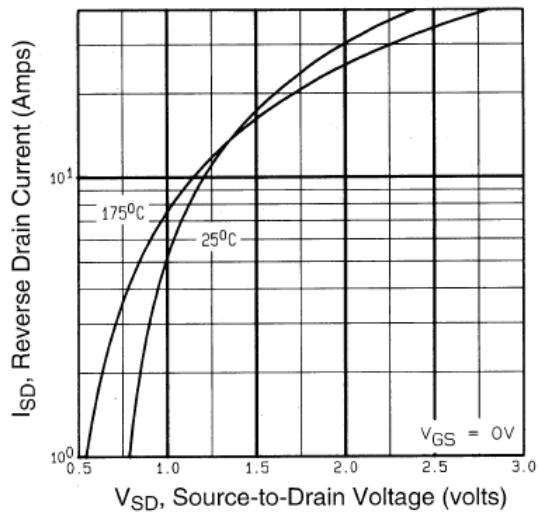


Fig. 7 - Typical Source-Drain Diode Forward Voltage

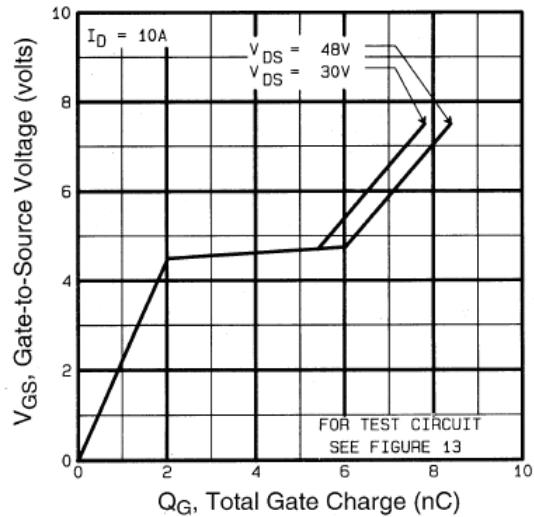


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

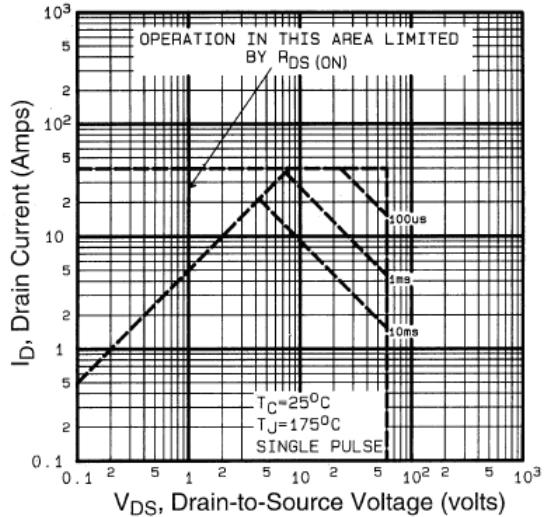


Fig. 8 - Maximum Safe Operating Area

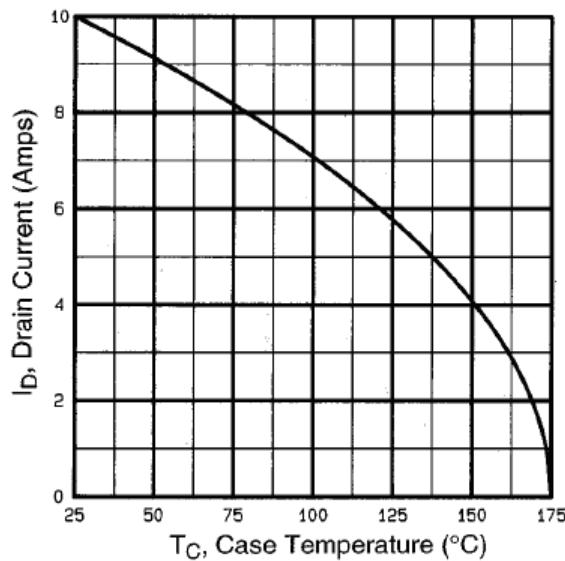


Fig. 9 - Maximum Drain Current vs. Case Temperature

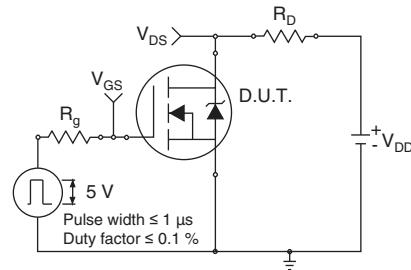


Fig. 10a - Switching Time Test Circuit

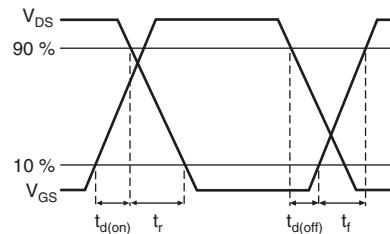


Fig. 10b - Switching Time Waveforms

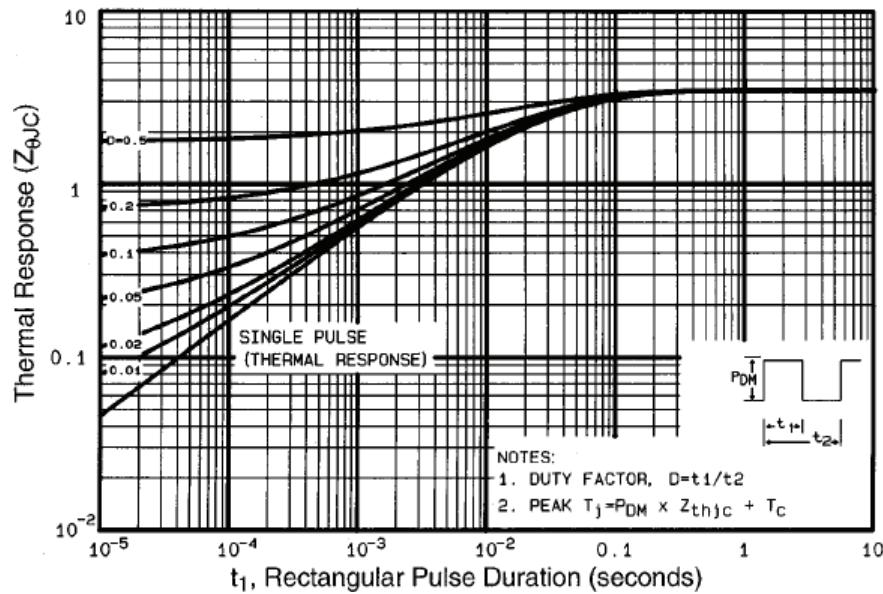


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRLZ14S, IRLZ14L, SiHLZ14S, SiHLZ14L

Vishay Silicon IRLZ14S, IRLZ14L, SiHLZ14S, SiHLZ14L"供应商

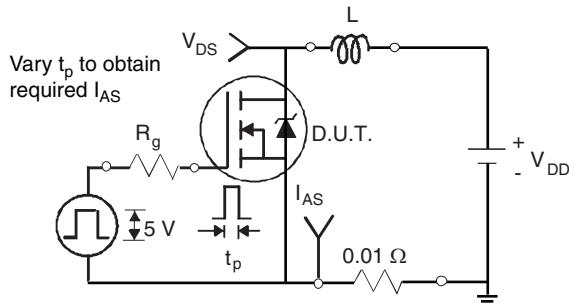


Fig. 12a - Unclamped Inductive Test Circuit

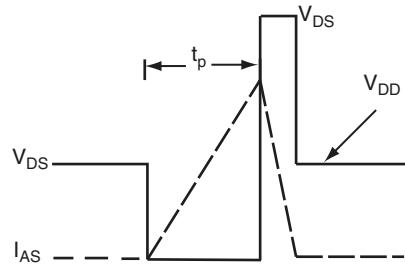


Fig. 12b - Unclamped Inductive Waveforms

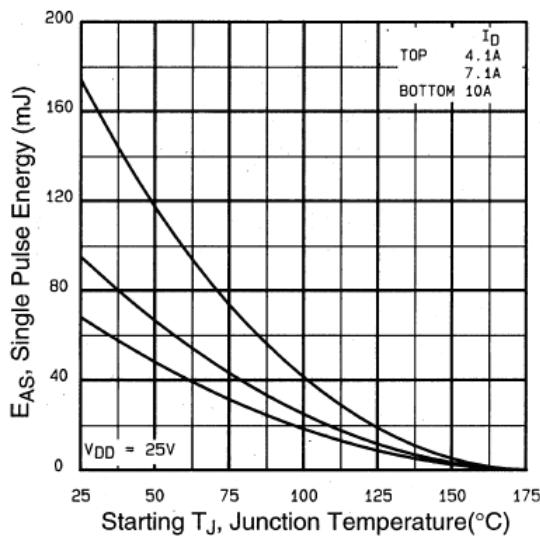


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

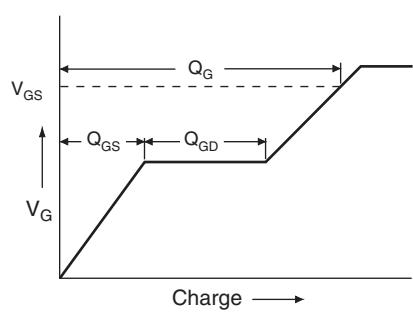


Fig. 13a - Basic Gate Charge Waveform

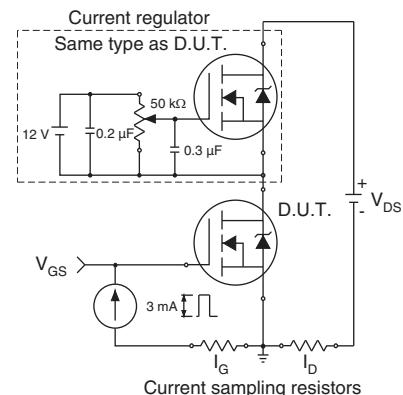
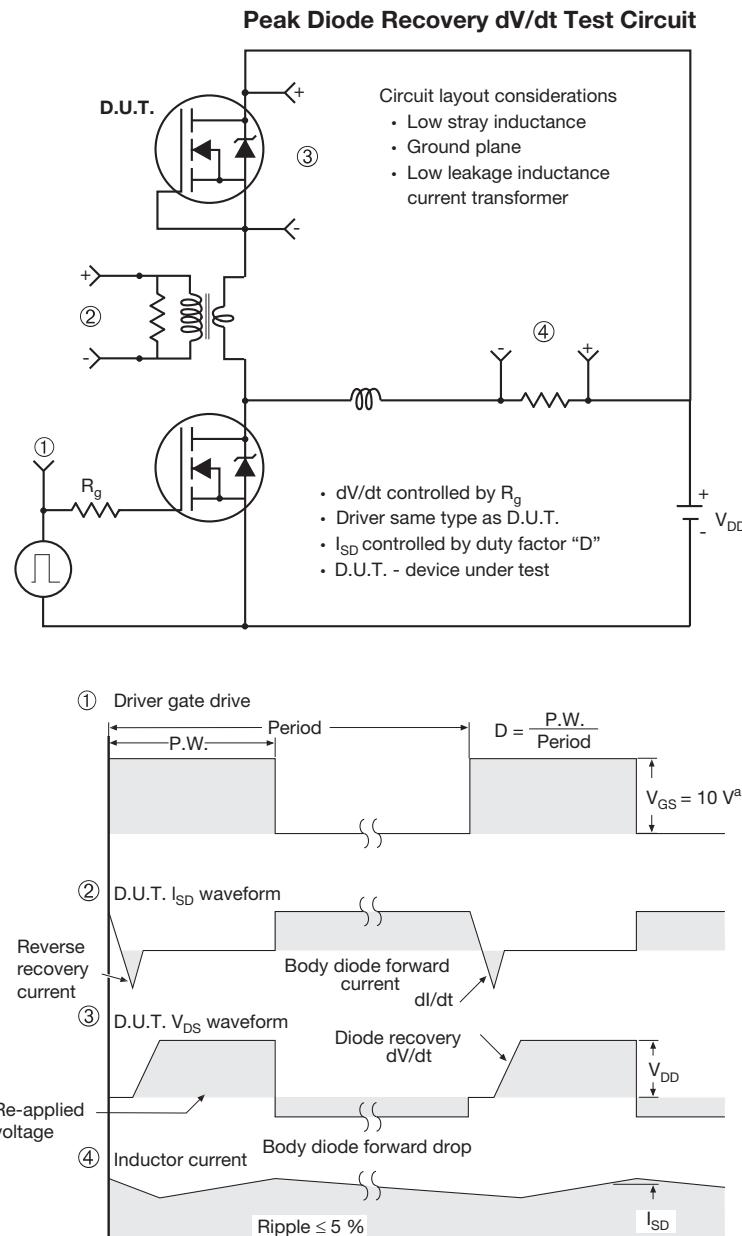


Fig. 13b - Gate Charge Test Circuit


**Fig. 14 - For N-Channel**

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <http://www.vishay.com/ppg?90414>.

## **Disclaimer**

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.